

E.S.D NOISE CLIPPING DIODES

NNCD3.3G to NNCD7.5G, NNCD27G

ELECTROSTATIC DISCHARGE NOISE CLIPPING DIODES (QUARTO TYPE : COMMON ANODE) 5 PIN MINI MOLD

This product series is a diode developed for E.S.D (Electrostatic Discharge) noise protection. Based on the IEC1000-4-2 test on electromagnetic interference (EMI), the diode assures an endurance of no less than 30 KV, thus making itself most suitable for external interface circuit protection.

With four elements mounted in the 5 PIN Mini Mold Package, the product can cope with high density and automatic packaging.

FEATURES

- Based on the electrostatic discharge immunity test (IEC1000-4-2), the product assures the minimum endurance of 30 KV.
- Based on the reference supply of the set, the product achieves a series over a wide range (11 product name lined up).
- With 4 elements mounted (common anode) mounted in the 5 PIN MINI MOLD package, the product can achieve a high density and automatic packaging.

APPLICATIONS

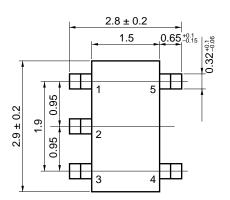
- External interface circuit E.S.D protection.
- · Circuits for Waveform clipper, Surge absorber.

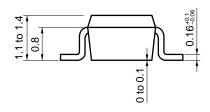
MAXIMUM RATINGS (TA = 25 °C)

Power Dissipation P 200 mW (Total) Surge Reverse Power PRSM 85 W (t = 10 μ s 1 pulse) Fig. 5 Junction Temperature T_j 150 °C

Storage Temperature T_{stg} -55 °C to +150 °C

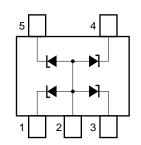
PACKAGE DIMENSIONS (in millimeters)





(5 PIN mini MOLD) (SC-74A)

PIN CONNECTION



1 : K1 Cathode 1
2 : A Anode (common)
3 : K2 Cathode 2
4 : K3 Cathode 3
5 : K4 Cathode 4



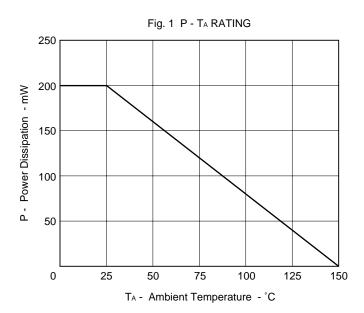
ELECTRICAL CHARACTERISTICS (T_A = 25 °C) (A-K1, A-K2, A-K3, A-K4)

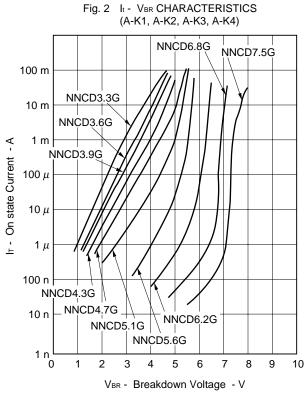
Parameter	Breakdown Voltage* VBR (V)			Dynamic** Impedance Z _z (Ω)		Reverse Leakage IR (μΑ)		Capacitance Ct (pF)		E.S.D Voltage (KV)	
	MIN.	MAX.	Iτ (mA)	MAX.	Iτ (mA)	MAX.	V _R (V)	TYP.	Test Condition	MIN.	Test Condition
NNCD3.3G	3.10	3.50	5	130	5	20	1.0	220	V _R = 0 V - f = 1 MHz	30	C = 150 pF R = 330 Ω (IEC1000 -4-2)
NNCD3.6G	3.40	3.80	5	130	5	10	1.0	210		30	
NNCD3.9G	3.70	4.10	5	130	5	10	1.0	200		30	
NNCD4.3G	4.01	4.48	5	130	5	10	1.0	180		30	
NNCD4.7G	4.42	4.90	5	130	5	10	1.0	170		30	
NNCD5.1G	4.84	5.37	5	130	5	5	1.5	160		30	
NNCD5.6G	5.31	5.92	5	80	5	5	2.5	140		30	
NNCD6.2G	5.86	6.53	5	50	5	2	3.0	120		30	
NNCD6.8G	6.47	7.14	5	30	5	2	3.5	110		30	
NNCD7.5G	7.06	7.84	5	30	5	2	4.0	90		30	
NNCD27G	25.10	28.90	2	70	2	2	21	25		30	

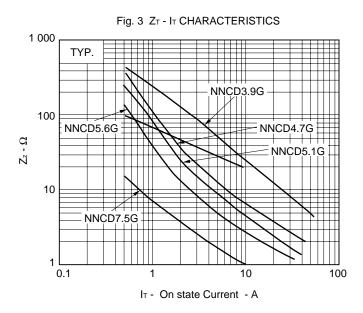
^{*} Tested with pulse (40 ms)

^{**} Z_z is measured at I_T give a small A.C. signal.

TYPICAL CHARACTERISTICS (TA = 25 °C)







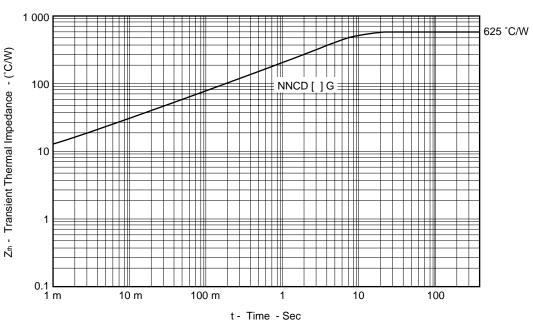
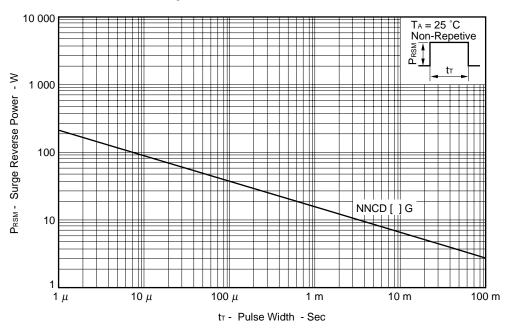
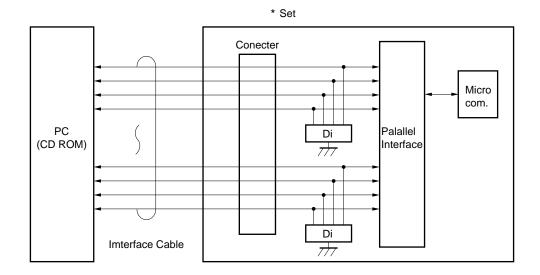


Fig. 4 TRANSIENT THERMAL IMPEDANCE





Sample Application Circuits



* Set Printer, P.D.C, T.V Game etc



REFERENCE

Document Name	Document No.		
NEC semiconductor device reliability/quality control system	C11745E		
NEC semiconductor device reliability/quality control system	MEI-1201		
Quality grade on NEC semiconductor devices	C11531E		
Semiconductor device mounting technology manual	C10535E		
Guide to quality assurance for semiconductor device	MEI-1202		

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Anti-radioactive design is not implemented in this product.

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